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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

NIMROD SARIG

Application No.: 10/072,313

Filed: February 07, 2002

For: **Method and System For Detection Defects**

Art Group: 2825

Examiner: Kik, Phallaka

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

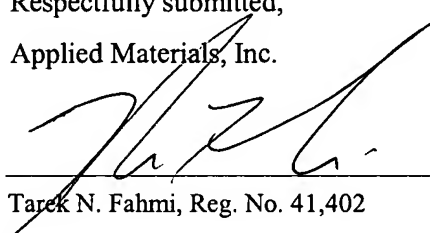
TRANSMITTAL OF FORMAL DRAWINGS

Sir:

Enclosed herewith for filing in the above-identified U.S. Patent Application are the formal drawings, 24 sheets including 40 Figures. Please charge any additional fees or credit any overpayment to Deposit Account No. 02-2666. A duplicate copy of the Fee Transmittal is enclosed for this purpose.

Respectfully submitted,
Applied Materials, Inc.

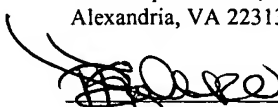
Dated: March 17, 2004


Tarek N. Fahmi, Reg. No. 41,402

Patent Counsel
P.O. Box 450A
Santa Clara, CA 95052
Telephone: (408) 947-8200

CERTIFICATE OF MAILING/TRANSMISSION

I hereby certify that this correspondence is being deposited with the United States Postal Service on the date shown below with sufficient postage as first class mail in an envelope addressed to: Mail Stop Issue Fee, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.


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